

<b>Notice of References Cited</b>	Application/Control No. 10/606,620	Applicant(s)/Patent Under Reexamination HWANG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,526,835	07-1985	Takahashi et al.	428/413
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 57137318 A	08-1982	Japan	KIYONO, SHIGEO	C08G 59/56
	O	JP 61246227 A	11-1986	Japan	HINO et al.	C08G 59/50
	P	JP 04338691 A	11-1992	Japan	NONOGAKI et al.	H05K 01/03
	Q	JP 08231829 A	09-1996	Japan	WATANABE et al.	C08L 63/00
	R	JP 08295723 A	11-1996	Japan	IJIMA et al.	C08G 59/50
	S	GB 1133564 A	11-1969	Great Britain	CIBA Limited	C08G 30/10
	T	DE 3329695 A	03-1985	Germany	AICHELE, W	C08G 59/32

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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